

Notice of References Cited	Application/Control No. 10/606,844	Applicant(s)/Patent Under Reexamination IWAHARA ET AL.	
	Examiner Craig A. Renner	Art Unit 2652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0135016 A1	06-2005	Ohwe, Takeshi	360/245.9
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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